



Sanken Power Devices from Allegro MicroSystems

# **STR-A6259H**

# Universal-Input 13 W 100 kHz Flyback Switching Regulators

suitching rs



Package DIP-8

Approximate Scale 1:1



- 100 kHz PWM with ±5% frequency jittering for EMI noise filtering cost reduction
- Rugged 650 V avalanche-rated MOSFET:
  - · Simplified surge absorption
  - No V<sub>DSS</sub> derating required
- Low  $R_{DS(on)}$ : 6  $\Omega$  maximum
- Auto-burst mode for stand-by operation or light loads; less transformer audible noise
- Built-in leading edge blanking
- Soft start and low start-up current; start-up circuit disabled in operation
- Auto-burst stand-by (intermittent operation) input power <0.1 W at no load
- Built-in constant-voltage/constant current (CV/CC)
- Multiple protections:
  - Pulse-by-pulse overcurrent protection (OCP)
  - · Overload protection (OLP) with auto restart
  - Latching overvoltage protection (OVP)
  - · Undervoltage lockout (UVLO) with hysteresis
  - Latching thermal shutdown (TSD)

The STR-A6259H is a 100 kHz PWM topology (with  $\pm$ 5% frequency jittering for minimum EMI) regulator specifically designed to satisfy the requirements for increased integration and reliability in flyback converters. It incorporates a primary control and drive circuit with an avalanche-rated power MOSFET.

Covering the power range from below 17 watts for a 230 VAC input, or to 13 watts for a universal (85 to 264 VAC) input, this device can be used in a wide range of applications, from DVD players and VCR player/recorders to ac adapters for cellular phones and digital cameras. An auto-burst standby function reduces power consumption at light load, while multiple protections, including the avalanche-energy guaranteed MOSFET, provide high reliability of system design.

Cycle-by-cycle current limiting, undervoltage lockout with hysteresis, overvoltage protection, and thermal shutdown protect the power supply during the normal overload and fault conditions. Overvoltage protection and thermal shutdown are latched after a short delay. The latch may be reset by cycling the input supply. Low start-up current and a low-power standby mode selected from the secondary circuit completes a comprehensive suite of features.

It is provided in an 8-pin mini-DIP plastic package with pin 6 removed. The leadframe plating is pure Sb, and the package complies with RoHS.

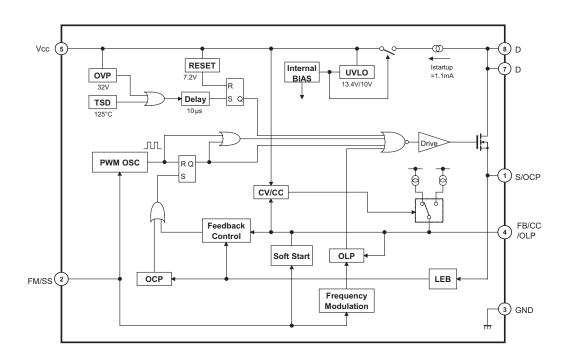


All performance characteristics given are typical values for circuit or system baseline design only and are at the nominal operating voltage and an ambient temperature of  $\pm 25$ °C, unless otherwise stated.

Always order by complete part number, e.g.:

STR-A6259H

### FUNCTIONAL BLOCK DIAGRAM AND TERMINAL ASSIGNMENTS



Number	Name	Description	Functions
1	S/OCP	Source/OCP terminal	MOSFET Source/Overcurrent protection
2	FM/SS	FM/Soft start terminal	Capacitor connection terminal for frequency jitter and soft start.
3	GND	Ground terminal	Ground
4	FB /CC/OLP	FB/CC/OLP terminal	Input of constant voltage control signal / constant current operation control signal / over load protection signal
5	VCC	Power supply terminal	Input of power supply for control circuit
7	D	Drain terminals	MOSFET drain / Input of startup
8	D	Diani terminais	current



Switching Regulators

### ABSOLUTE MAXIMUM RATINGS at $T_A = 25$ °C

Characteristic	Symbol	Terminal	Note	Max.	Unit
Drain Current <sup>1</sup>	I <sub>Dpeak</sub>	8-1	Single Pulse	1.8	Α
Maximum Switching Current	I <sub>DMAX</sub>	8-1	$V_{S/OCP}$ = 0.83 V with reference to GND, $T_A$ = -20 to 125°C	1.8	А
Single Pulse Avalanche Energy <sup>2</sup>	E <sub>AS</sub>	8-1	Single Pulse	24	mJ
Single Fulse Avaiantifie Energy-	LAS		V <sub>DD</sub> = 99 V, L = 20 mH, I <sub>L</sub> = 1.8 A	24	mJ
S/OCP Terminal Voltage	V <sub>OCP</sub>	1-3		-0.3 to 6	V
Controller (MIC) Input Voltage	Vcc	5-3		36	V
FB/CC/OLP Terminal Voltage	V <sub>FB</sub>	4-3		-0.3 to 11	V
FM Terminal Voltage	V <sub>FM</sub>	2-3		-0.3 to 6	V
MOSFET Power Dissipation <sup>3,4</sup>	P <sub>D1</sub>	8-1		1.35	W
Controller (MIC) Power Dissipation <sup>5</sup>	P <sub>D2</sub>	5-3	For Vcc×lcc	0.15	W
Operating Internal Frame Temperature <sup>6</sup>	T <sub>F</sub>		Refer to T <sub>OP</sub>	-20 to 125	°C
Operating Ambient Temperature	T <sub>op</sub>			-20 to 125	°C
Storage Temperature	T <sub>stg</sub>			-40 to 125	°C
Channel Junction Temperature	TJ			150	°C

<sup>&</sup>lt;sup>1</sup>Refer to figure 1

Figure 1 – MOSFET Safe Operating Area Derating Curve

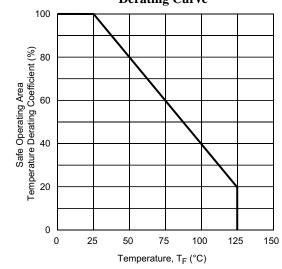
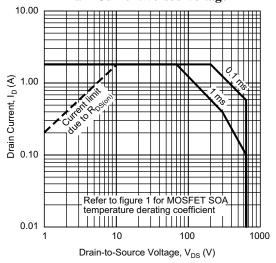


Figure 2 – MOSFET Safe Operating Area Drain Current versus Voltage





<sup>&</sup>lt;sup>2</sup>Refer to figure 3

<sup>&</sup>lt;sup>3</sup>Refer to figure 5

<sup>&</sup>lt;sup>4</sup>Mounted on 15 x 15 mm printed circuit board

<sup>&</sup>lt;sup>5</sup>Refer to figure 6

<sup>&</sup>lt;sup>6</sup>Measured at the root of terminal 3

Figure 3 – MOSFET Avalanche Energy Derating Curve

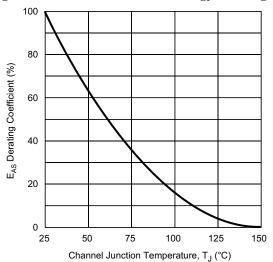


Figure 5 – MOSFET Power Dissipation versus Temperature

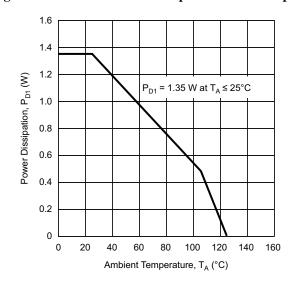
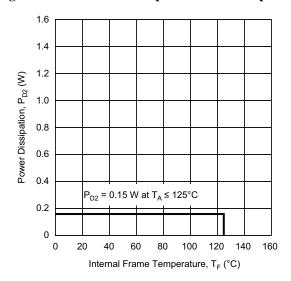


Figure 6 – MIC Power Dissipation versus Temperature





Switching Regulators

ELECTRICAL CHARACTERISTICS for Controller (MIC), valid at T<sub>A</sub> = 25°C, V<sub>CC</sub> = 18 V, unless otherwise specified

Characteristic	Symbol	Terminal	Test Conditions	Min.	Тур.	Max.	Unit
Operation Start Voltage V <sub>CC(ON)</sub> 5		5-3	(Power supply voltage at which device starts operating) Measurement circuit 1, V <sub>CC</sub> = 0 though 13.1 to 16.1 V	12.9	14.3	15.7	V
Operation Stop Voltage V <sub>CC(OFF)</sub>		5-3	(Power supply voltage at which device stops operating) Measurement circuit 1, V <sub>CC</sub> = 16.1 through 9 to 11 V	9	10	11	V
Circuit Current In Operation	I <sub>CC(ON)</sub>	5-3	(Inflow current into power supply terminal, in operation) Measurement circuit 1	_	_	4	mA
Initialization Circuit Current	I <sub>CC(OFF)</sub>	5-3	(Inflow current into power supply terminal, while subject to UVLO prior to operation) Measurement circuit 1, $V_{\rm CC}$ = 13 V	-	-	25	μA
Center Switching Frequency	$f_{osc(av)}$	8-3	(Center oscillation frequency of D terminal) Measurement circuit 2	90	100	110	KHz
Frequency Jitter Deviation	Δf	8-3	Maximum frequency – minimum frequency Measurement circuit 2	6	10	14	kHz
Maximum Duty Cycle	D <sub>MAX</sub>	8-3	(Maximum width of the low portion of the D terminal waveform) Measurement circuit 2	70	76	82	%
FM High Voltage	$V_{HFM}$	2-3	(V <sub>FM</sub> at which the FM current is changed from 10 μA to –10 μA) Measurement circuit 2	4.0	4.5	5.0	V
FM Low Voltage	$V_{LFM}$	2-3	(V <sub>FM</sub> at which the FM current is changed from –10 μA to 10 μA) Measurement circuit 2	3.2	3.6	4.0	V
FM Outflow Current	I <sub>sorcFM</sub>	2-3	Outflow current from FM terminal at V <sub>FM</sub> = V <sub>LFM</sub> (3.7 V typ.) Measurement circuit 2	7.7	11	15.4	μΑ
FM Inflow Current	I <sub>sinkFM</sub>	2-3	Inflow current into FM terminal at $V_{FM} = V_{HFM} (4.4 \text{ V typ.})$ Measurement circuit 2	-15.4	-11	-7.7	μА
OCP Threshold Voltage	V <sub>OCP(th)</sub>	1-3	(The drain current at which the low portion of the D terminal waveform becomes shorter than the high portion, with $V_{\rm OCP}$ increasing) Measurement circuit 3	0.67	0.74	0.81	V
Leading Edge Blanking Time	t <sub>wb</sub>	8-3	(The low portion of the D terminal waveform with V <sub>OCP</sub> = 1 V) Measurement circuit 3	240	350	460	ns
Burst Threshold Voltage	V <sub>burst(th)</sub>	4-3	(FB/CC/OLP terminal voltage at which D terminal waveform oscillation stops due to V <sub>FB</sub> decreasing from 5 V) Measurement circuit 4	1.0	1.12	1.24	V
OLP Threshold Voltage	$V_{OLP(th)}$	4-3	(FB/CC/OLP terminal voltage at which D terminal waveform oscillation stops due to V <sub>FB</sub> increasing from 5 V) Measurement circuit 4	7.3	8.6	9.9	V
Output Current at OLP Operation	I <sub>OLP</sub>	4-3	(Outflow current from FB/CC/OLP terminal at V <sub>FB</sub> = 8 V) Measurement circuit 4	12	18	25	μA
OLP Delay Time	T <sub>OLP</sub>	4-3	(Time between surpassing V <sub>OLP(th)</sub> and stop of oscillation) Measurement circuit 4	0.84	1.2	1.56	S
Maximum Feedback Current	I <sub>FB(MAX)</sub>	4-3	(Outflow current from FB/CC/OLP terminal at V <sub>FB</sub> = 0 V) Measurement circuit 4	220	310	430	μА

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Switching Regulators

ELECTRICAL CHARACTERISTICS for Controller (MIC) continued, valid at T<sub>A</sub> = 25°C, V<sub>CC</sub> = 18 V, unless otherwise specified

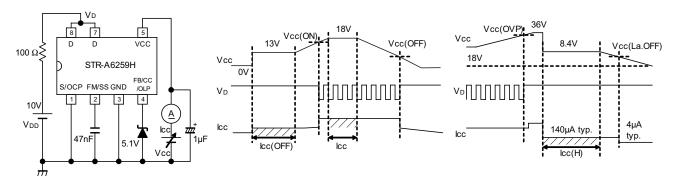
1100 101 00111101	()	ontineda, vana at 14 20 0, vee 10 v, amood outerwise op	oomoa			
V <sub>SET(CC)</sub>	4-3	(FB/CC/OLP terminal voltage at which $I_{FB}$ changes from 280 $\mu A$ to 16 $\mu A$ due to $V_{FB}$ increasing from 5 V) Measurement circuit 4	4.9	5.8	6.7	V
Constant Current Reset Voltage VRES(CC) 4-3		(FB/CC/OLP terminal voltage at which $I_{FB}$ changes from 16 $\mu$ A to 280 $\mu$ A due to $V_{FB}$ decreasing from 8 V) $V_{RES(CC)} \times V_{CC} = 25$ V, Measurement circuit 4, $V_{CC} = 25$ V	3.5	3.9	4.3	V
		(Outflow current from V <sub>CC</sub> terminal at V <sub>DD</sub> = 600 V) Measurement circuit 5, V <sub>CC</sub> = 13 V	0.77	1.1	1.43	mA
$V_{CC(OVPth)}$	5-3	( $V_{CC}$ at which the oscillation of the D terminal waveform stops due to $V_{CC}$ increasing from 18 V) Measurement circuit 1, $V_{CC}$ = 18 through 31 to 35.2 V	28.8	32	35.2	V
I <sub>CC(H)</sub>	5-3	(Inflow current into VCC at $V_{CC}$ = 8.4 V, after OVP operation) Measurement circuit 1, $V_{CC}$ = 35.2 to 8.6 V	_	-	270	μА
V <sub>CC(LaOFF)</sub>	5-3	$(V_{CC}$ at which $I_{CC}$ drops below 20 μA due to decreasing $V_{CC}$ after OVP operation) Measurement circuit 1, $V_{CC}$ = 35.2 through 5.9 to 8.6 V	5.9	7.2	8.6	V
$T_{J(TSD)}$			125	140	_	°C
TICS for MOSFI	T, valid at	T <sub>A</sub> = 25°C, V <sub>CC</sub> = 18 V, unless otherwise specified				
$V_{DSS}$	8-1	Measurement circuit 6, I <sub>D</sub> = 300 μA	650	-	_	V
I <sub>DSS</sub>	8-1	(Inflow current into D terminal at V <sub>DD</sub> = 650 V) Measurement circuit 5	-	-	300	μΑ
R <sub>DS(ON)</sub>	8-1	Measurement circuit 3, I <sub>D</sub> = 0.4 A	_	_	6	Ω
t <sub>f</sub>	8-1	Measurement circuit 2	-	_	250	ns
Thermal Resistance R <sub>ech-F</sub>		Between channel and internal frame; measured at the root of terminal 3	-	-	52	°C/W
	VSET(CC)  VRES(CC)  Istartup  VCC(OVPth)  ICC(H)  VTJ(TSD)  TICS for MOSFE  VDSS  IDSS  RDS(ON)  tf	VSET(CC)         4-3           VRES(CC)         4-3           Istartup         6-3           VCC(OVPth)         5-3           ICC(H)         5-3           VCC(LaOFF)         5-3           TJ(TSD)         TICS for MOSFET, valid at           VDSS         8-1           IDSS         8-1           RDS(ON)         8-1           tf         8-1	$V_{SET(CC)} = \begin{array}{c} 4-3 & (FB/CC/OLP \ terminal \ voltage \ at \ which \ I_{FB} \ changes \ from \ 280 \ \mu A \ to 16 \ \mu A \ due \ to \ V_{FB} \ increasing \ from 5 \ V) \ Measurement \ circuit \ 4 \\ \hline V_{RES(CC)} = \begin{array}{c} 4-3 & (FB/CC/OLP \ terminal \ voltage \ at \ which \ I_{FB} \ changes \ from \ 16 \ \mu A \ to 280 \ \mu A \ due \ to \ V_{FB} \ decreasing \ from 8 \ V) \ V_{RES(CC)} \times V_{CC} = 25 \ V, \ Measurement \ circuit \ 4, \ V_{CC} = 25 \ V \end{array}$ $I_{Startup} = \begin{array}{c} 6-3 & (Outflow \ current \ from \ V_{CC} \ terminal \ at \ V_{DD} = 600 \ V) \ Measurement \ circuit \ 5, \ V_{CC} = 13 \ V \end{array}$ $V_{CC(OVPth)} = \begin{array}{c} 5-3 & (Outflow \ current \ from \ V_{CC} \ terminal \ at \ V_{DD} = 600 \ V) \ Measurement \ circuit \ 1, \ V_{CC} = 18 \ through \ 31 \ to \ 35.2 \ V \end{array}$ $I_{CC(H)} = \begin{array}{c} 5-3 & (Inflow \ current \ into \ VCC \ at \ V_{CC} = 18 \ through \ 31 \ to \ 35.2 \ V \end{array}$ $I_{CC(H)} = \begin{array}{c} 5-3 & (Inflow \ current \ into \ VCC \ at \ V_{CC} = 8.4 \ V, \ after \ OVP \ operation) \ Measurement \ circuit \ 1, \ V_{CC} = 35.2 \ to \ 8.6 \ V \end{array}$ $V_{CC(LaOFF)} = \begin{array}{c} 5-3 & (V_{CC} \ at \ which \ I_{CC} \ drops \ below \ 20 \ \mu A \ due \ to \ decreasing \ V_{CC} \ after \ OVP \ operation) \ Measurement \ circuit \ 1, \ V_{CC} = 35.2 \ through \ 5.9 \ to \ 8.6 \ V \end{array}$ $T_{J(TSD)} = \begin{array}{c} T_{J(TSD)} = \begin{array}{c} 5-3 & (V_{CC} \ at \ which \ I_{CC} \ drops \ below \ 20 \ \mu A \ due \ to \ decreasing \ V_{CC} \ after \ OVP \ operation) \ Measurement \ circuit \ 1, \ V_{CC} = 35.2 \ through \ 5.9 \ to \ 8.6 \ V \end{array}$ $T_{J(TSD)} = \begin{array}{c} T_{J(TSD)} = \begin{array}{c} 5-3 & (I_{CC} \ at \ which \ I_{CC} \ at \ which \$	VSET(CC)4-3280 μA to 16 μA due to VFB increasing from 5 V) Measurement circuit 44.9 $V_{RES(CC)}$ 4-3(FB/CC/OLP terminal voltage at which $I_{FB}$ changes from 16 μA to 280 μA due to VFB decreasing from 8 V) VRES(CC) × VCC = 25 V, Measurement circuit 4, VCC = 25 V3.5 $I_{startup}$ 6-3(Outflow current from VCC terminal at VDD = 600 V) Measurement circuit 5, VCC = 13 V0.77 $V_{CC(OVPth)}$ 5-3(VCC at which the oscillation of the D terminal waveform stops due to VCC increasing from 18 V) Measurement circuit 1, VCC = 18 through 31 to 35.2 V28.8 $I_{CC(H)}$ 5-3(Inflow current into VCC at VCC = 8.4 V, after OVP operation) Measurement circuit 1, VCC = 35.2 to 8.6 V- $V_{CC(LaOFF)}$ 5-3(VCC at which ICC drops below 20 μA due to decreasing VCC after OVP operation) Measurement circuit 1, VCC = 35.2 through 5.9 to 8.6 V5.9 $TICS$ for MOSFET, valid at $T_A = 25^{\circ}$ C, VCC = 18 V, unless otherwise specified125 $V_{DSS}$ 8-1Measurement circuit 6, ID = 300 μA650 $I_{DSS}$ 8-1(Inflow current into D terminal at VDD = 650 V) Measurement circuit 5- $I_{DSS}$ 8-1Measurement circuit 3, ID = 0.4 A- $I_{F}$ 8-1Measurement circuit 2- $I_{F}$ 8-1Measurement circuit 2- $I_{F}$ Between channel and internal frame; measured at the root-	$V_{SET(CC)} = \begin{cases} 4-3 & (FB/CC/OLP \ terminal \ voltage \ at \ which \ I_{FB} \ changes \ from \\ 280 \ \mu A \ to \ 16 \ \mu A \ due \ to \ V_{FB} \ increasing \ from \ 5 \ V) \\ Measurement \ circuit \ 4 \end{cases}$ $V_{RES(CC)} = \begin{cases} 4-3 & (FB/CC/OLP \ terminal \ voltage \ at \ which \ I_{FB} \ changes \ from \\ 16 \ \mu A \ to \ 280 \ \mu A \ due \ to \ V_{FB} \ decreasing \ from \ 8 \ V) \\ V_{RES(CC)} \times V_{CC} = 25 \ V, \ Measurement \ circuit \ 4, \ V_{CC} = 25 \ V \end{cases}$ $I_{Startup} = \begin{cases} 6-3 & (Outflow \ current \ from \ V_{CC} \ terminal \ at \ V_{DD} = 600 \ V) \\ Measurement \ circuit \ 5, \ V_{CC} = 13 \ V \end{cases}$ $V_{CC(OVPth)} = \begin{cases} 5-3 & (V_{CC} \ at \ which \ the \ oscillation \ of \ the \ D \ terminal \ waveform \ stops \ due \ to \ V_{CC} \ increasing \ from \ 18 \ V) \\ Measurement \ circuit \ 1, \ V_{CC} = 18 \ through \ 31 \ to \ 35.2 \ V \end{cases}$ $I_{CC(H)} = \begin{cases} 5-3 & (Inflow \ current \ into \ VCC \ at \ V_{CC} = 8.4 \ V, \ after \ OVP \ operation) \\ Measurement \ circuit \ 1, \ V_{CC} = 35.2 \ to \ 8.6 \ V \end{cases}$ $V_{CC(LaOFF)} = \begin{cases} 5-3 & (V_{CC} \ at \ which \ I_{CC} \ drops \ below \ 20 \ \mu A \ due \ to \ decreasing \ V_{CC} \ after \ OVP \ operation) \\ Measurement \ circuit \ 1, \ V_{CC} = 35.2 \ through \ 5.9 \ to \ 8.6 \ V \end{cases}$ $T_{J(TSD)} = \begin{cases} V_{CC} \ at \ which \ I_{CC} \ drops \ below \ 20 \ \mu A \ due \ to \ decreasing \ V_{CC} \ after \ OVP \ operation) \\ Measurement \ circuit \ 1, \ V_{CC} = 35.2 \ through \ 5.9 \ to \ 8.6 \ V \end{cases}$ $T_{J(TSD)} = \begin{cases} V_{DSS} = 8-1 & Measurement \ circuit \ 6, \ I_{D} = 300 \ \mu A \qquad 650 \qquad -1 \end{cases}$ $I_{DSS} = \begin{cases} 8-1 & Measurement \ circuit \ 5, \ I_{D} = 0.4 \ A \qquad -1 \qquad -1 \qquad -1 \ A \ Basilon \$	$V_{SET(CC)} = \begin{array}{c} 4-3 & (FB/CC/OLP \ terminal \ voltage \ at \ which \ I_{FB} \ changes \ from \ 280 \ \mu A \ to 16 \ \mu A \ due \ to \ V_{FB} \ increasing \ from 5 \ V) \\ Measurement \ circuit 4 & 4.9 & 5.8 & 6.7 \\ \hline V_{RES(CC)} = \begin{array}{c} 4-3 & (FB/CC/OLP \ terminal \ voltage \ at \ which \ I_{FB} \ changes \ from \ 8 \ V) \\ V_{RES(CC)} \times V_{CC} = 25 \ V, \ Measurement \ circuit 4, \ V_{CC} = 25 \ V \\ V_{RES(CC)} \times V_{CC} = 25 \ V, \ Measurement \ circuit 4, \ V_{CC} = 25 \ V \\ Measurement \ circuit 5, \ V_{CC} = 13 \ V & 0.77 & 1.1 & 1.43 \\ \hline V_{CC(IAOFI)} = \begin{array}{c} 5-3 & (Outflow \ current \ from \ V_{CC} \ terminal \ at \ V_{DD} = 600 \ V) \\ Measurement \ circuit 5, \ V_{CC} = 13 \ V & 0.77 & 1.1 & 1.43 \\ \hline V_{CC(IAOFF)} = \begin{array}{c} 5-3 & (V_{CC} \ at \ which \ the \ oscillation \ of \ the \ D \ terminal \ waveform \ stops \ due \ to \ V_{CC} \ increasing \ from \ 18 \ V) \\ Measurement \ circuit 1, \ V_{CC} = 18 \ through \ 31 \ to \ 35.2 \ V \\ \hline V_{CC(IAOFF)} = \begin{array}{c} 5-3 & (Inflow \ current \ into \ VCC \ at \ V_{CC} = 35.2 \ to \ 8.6 \ V \\ \hline V_{CC(IAOFF)} = \begin{array}{c} 5-3 & (V_{CC} \ at \ which \ I_{CC} \ drops \ below \ 20 \ \mu A \ due \ to \ decreasing \ V_{CC} \ at \ which \ I_{CC} \ e \ 35.2 \ through \ 5.9 \ for \ 8.6 \ V \\ \hline T_{J(TSD)} = \begin{array}{c} 5-3 & (V_{CC} \ at \ which \ I_{CC} \ e \ 18 \ V, \ unless \ otherwise \ specified \\ \hline V_{DSS} = \begin{array}{c} 8-1 & Measurement \ circuit \ 6, \ I_D = 300 \ \mu A & 650 \ - \ - \\ \hline I_{DSS} = \begin{array}{c} 8-1 & (Inflow \ current \ into \ D \ terminal \ at \ V_{DD} = 650 \ V) \\ Measurement \ circuit \ 3, \ I_D = 0.4 \ A & - \ - \ 6 \\ \hline I_T = \begin{array}{c} 8-1 & Measurement \ circuit \ 3, \ I_D = 0.4 \ A & - \ - \ - \ 6 \\ \hline I_T = \begin{array}{c} 8-1 & Measurement \ circuit \ 2 \ - \ - \ 250 \\ \hline \end{array}$

<sup>&</sup>lt;sup>1</sup>Latch circuit enabled when OVP and TSD in operation

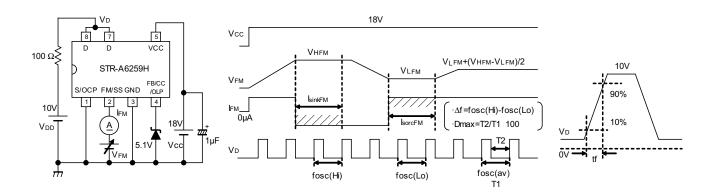


Switching Regulators

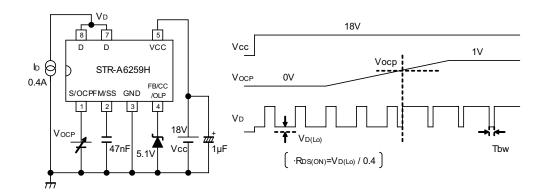
### **Measurement Circuit 1**



### **Measurement Circuit 2**

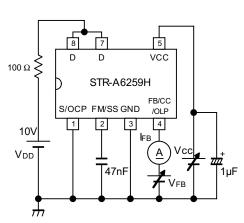


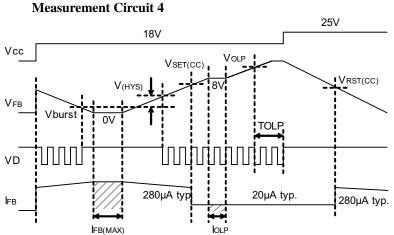
### **Measurement Circuit 3**





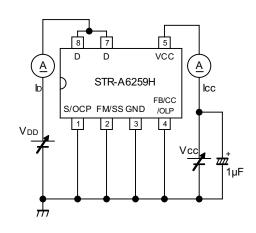
# Switching Regulators

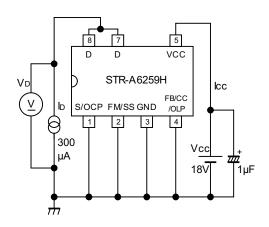




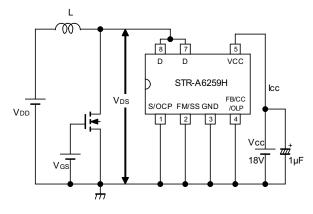
### **Measurement Circuit 5**

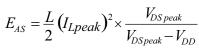
### **Measurement Circuit 6**

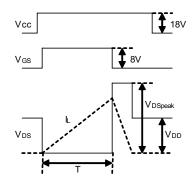




### **Measurement Circuit 7**







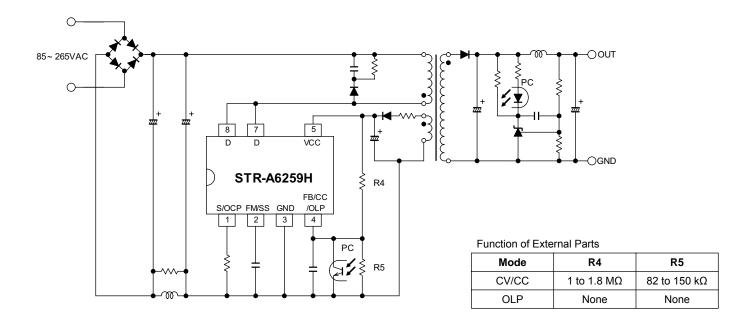
Adjust T such that  $I_{Lpeak} = 1.8 \text{ A}$ 





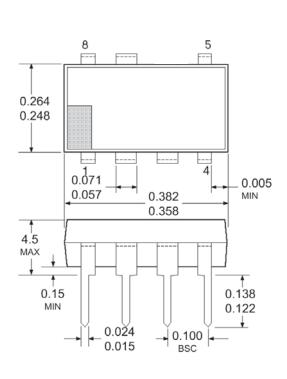
### TYPICAL APPLICATION CIRCUIT

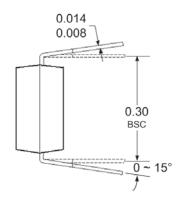
For improved thermal dissipation, connect terminals 7 and 8 to as large an area of exposed copper as possible



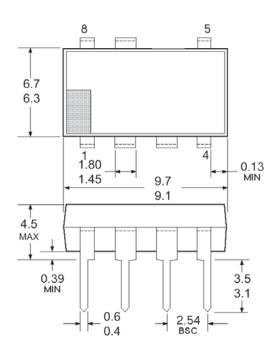


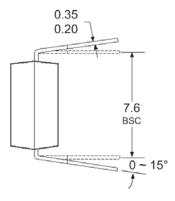
### PACKAGE DIMENSIONS, DIP-8





Dimensions in Inches (for reference only)





Dimensions in Millimeters (controlling dimensions)



Switching Regulators

### PACKING SPECIFICATIONS Minimum packing option: Tubes

Stopper, with attached tab Stopper, with Orientation of Devices in no tab **Shipping Tubes** 50 pieces Type A Type B 6.0 5.8 **Shipping Tube Dimensions** 505<sup>±1.0</sup> 504<sup>±1.0</sup> **Inner Carton Dimensions** Capacity: 50 tubes per inner carton **Outer Carton Dimensions** Capacity: 4 inner cartons per outer carton; 10,000 devices maximum per outer carton 290



All dimensions: mm

265





**WARNING** — These devices are designed to be operated at lethal voltages and energy levels. Circuit designs that embody these components must conform with applicable safety requirements. Precautions must be taken to prevent accidental contact with power-line potentials. Do not connect grounded test equipment.

The use of an isolation transformer is recommended during circuit development and breadboarding.

Because reliability can be affected adversely by improper storage environments and handling methods, please observe the following cautions.

### **Cautions for Storage**

- Ensure that storage conditions comply with the standard temperature (5°C to 35°C) and the standard relative humidity (around 40 to 75%); avoid storage locations that experience extreme changes in temperature or humidity.
- Avoid locations where dust or harmful gases are present and avoid direct sunlight.
- Reinspect for rust in leads and solderability of products that have been stored for a long time.

### **Cautions for Testing and Handling**

When tests are carried out during inspection testing and other standard test periods, protect the products from power surges from the testing device, shorts between adjacent products, and shorts to the heatsink.

### Remarks About Using Silicone Grease with a Heatsink

- When silicone grease is used in mounting this product on a heatsink, it shall be applied evenly and thinly. If more silicone grease than required is applied, it may produce stress.
- Volatile-type silicone greases may produce cracks after long periods of time, resulting in reduced heat radiation effect. Silicone grease with low consistency (hard grease) may cause cracks in the mold resin when screwing the product to a heatsink.
- Our recommended silicone greases for heat radiation purposes, which will not cause any adverse effect on the product life, are indicated below:

Туре		Suppliers
	G746	Shin-Etsu Chemical Co., Ltd.
	YG6260	Toshiba Silicone Co., Ltd.
	SC102	Dow Corning Toray Silicone Co., Ltd.

### Soldering

When soldering the products, please be sure to minimize the working time, within the following limits:

260±5°C 10 s 350±5°C 3 s

Soldering iron should be at a distance of at least 1.5 mm from the body of the products

### **Electrostatic Discharge**

- When handling the products, operator must be grounded. Grounded wrist straps worn should have at least 1  $M\Omega$  of resistance to ground to prevent shock hazard.
- Workbenches where the products are handled should be grounded and be provided with conductive table and floor mats.
- When using measuring equipment such as a curve tracer, the equipment should be grounded.
- When soldering the products, the head of soldering irons or the solder bath must be grounded in other to prevent leak voltages generated by them from being applied to the products.
- The products should always be stored and transported in our shipping containers or conductive containers, or be wrapped in aluminum foil.





Switching Switching

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